



Measuring CLAS12 D(e,e' π) Cross Sections for e4v

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I D E A FUSION



Neutrino Experiments



Far Detector

Neutrino Flux:



Neutrino experiments are difficult

- Large beam energy spread
- Small cross sections

Need GENIE to extract the neutrino flux from data

How to validate GENIE?





Electrons vs. Neutrinos

• Monoenergetic • Larger cross sections • Similar interactions • Electro-weak • Currents e^{-} v^{*} v^{*} N v_{l} N v_{l} v_{l} v_{l}

EM Current:

If GENIE can describe neutrinos, it can describe electrons

$$j^{em}_{\mu} = \overline{u} \gamma^{\mu} u$$

Vector

Charge-Coupling Weak Current:

$$j_{\mu}^{\pm} = \bar{u} \frac{-ig_{W}}{2\sqrt{2}} (\gamma^{\mu} - \gamma^{\mu}\gamma^{5})u$$
Vector Axial

Motivation

- GENIE badly describes inclusive p(e,e') and D(e,e') scattering in pion production region
 - GENIE parameters are being tuned to better describe the data
- I will measure 4.2 GeV RG-B D(e,e'π) Forward Detector cross sections to improve GENIE





Model Descriptions

Onepigen

- arXiv:nucl-th/9807001v2
- Single pion event generator
- MAID2007 unitary isobar model

Eur. Phys. J. A34, (2007) 69-97

- GENIE
 - Phenomenological semi-classical event generator
 - Quasi-elastic scattering
 PRD 103 (2021) 113003
 - Baryon resonance production (Berger-Sehgal) PRD 76 (2007) 113004

Nucl.Phys. A645 (1999) 145-174

• DIS and non resonant production (Bodek-Yang) J. Phys. G: Nucl. Part. Phys. 29 (2003) 1899–1905

Compare data to models run through GEMC

Average radiative corrections (Rad/NoRad) calculated using one pigen $\pi^+: 0.65 \pm 0.07$ $\pi^-: 0.5 \pm 0.1$





Resonant Production

Non-Resonant Production



Fiducial Cuts



Beam

7



Vertex Cuts







Run Selection



Number of Trigger Electrons / Faraday Cup Charge

About 400 M events

Systematic Uncertainties

• Radiative 20% of correction

Sector-to-sector variation

$$var = \frac{1}{4} \sum_{i}^{sec} (y_i - \bar{y})^2 - \frac{1}{5} \sum_{i}^{sec} \sigma_i^2$$

• Normalization 10%?











Backup Slides













Rarita
































Rarita

















Oscillation Probability $P(n_m \to n_m) = \sin^2(2q_{23}) \times \sin^2\left(\frac{Dm_{32}^2L}{4E_n}\right)$



T2K PRD (2015)

Pion Physics

- Mesons consisting of combinations of u and d quarks and antiquarks
- Commonly produced in scattering experiments

Resonance Decay Production

Non-Resonant Production



DIS Production





$$Q^2 = -q^2 = (k - k')^2$$
$$W = \sqrt{M_N^2 + 2M_N\omega - Q^2}$$



CLAS12

- Forward Detector:
 - High Threshold Cerenkov Counter (HTCC) identifies scattered electrons
 - Drift Chambers (DC) measure charged particle momenta
 - Forward Time-of-Flight (FTOF) measures time-of-flight of charged particles
 - Electromagnetic Calorimeters (EC) identifies scattered electrons
 - Includes Pre-shower Calorimeter (PCAL)
- Central Detector:

Not used in this analysis



FTOF Best Fit

$$\Delta t = t_{start\ time} - \left[t_{FTOF} - \frac{L}{\beta_h(p)}\right]; \beta_h(p) = \frac{p}{\sqrt{p^2 + m^2}}$$



• Fiducial cuts select hits (or tracks) with near 100% efficiency



DC Fiducial Cuts



DC Fiducial Cuts





EC Fiducial Cuts

Required V, W > 14 cm (removed outer 2 bars)





Electron and Pion z Vertices

-8 cm < Vtz_e < 2 cm





Electron Perpendicular Vertices





Pi- Perpendicular Vertices



Vertex Z Difference (Electron – Pi+)

Fitted with gaussian

Cut = mean \pm 3 * σ





Vertex Z Difference (Electron – Pi-)



Vertex Z Difference (Electron – Pi+)

Fitted with gaussian

Cut = mean \pm 3 * σ





Vertex Z Difference (Electron – Pi-)

Fitted with gaussian

Cut = mean \pm 3 * σ





D(e,e'pi) Cross Sections

$$N_{events} = \frac{d^{6}\sigma}{d\Omega_{E}d\Omega_{\pi}dE'dT_{\pi}} \Delta\Omega_{E}\Delta\Omega_{\pi}\Delta E'\Delta T_{\pi} * N_{e}t_{tgt} * correction factors$$

$$What we want$$

$$N_{events} = \frac{d^{2}\sigma}{dWdT_{\pi}} \Delta W \Delta T_{\pi} * N_{e}t_{tgt} * correction factors$$

$$\frac{d^{2}\sigma}{d\omega dT_{\pi}} = \frac{N_{events}}{\Delta W \Delta T_{\pi}L} * corr. factors$$
Our formula

$$L = N_e * t_{tgt} \qquad \qquad N_e = \frac{Q_{tot}}{q_e} \qquad \qquad t_{tgt} = \frac{\rho_{tgt} l_{tgt} N_A}{mol_{tgt}}$$







Used similar procedure for semi-inc. cross sections



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